



# RADIO TEST REPORT


**Test Report No. : 10131705H-B**

**Applicant** : Mitsubishi Electric Corporation Himeji Works  
**Type of Equipment** : Smart Keyless System (Hand Unit)  
**Model No.** : SKEA7A-02  
**Test regulation** : FCC Part 15 Subpart C: 2013  
**FCC ID** : WAZSKEA7A02  
**Test Result** : Complied


1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

**Date of test:** January 21 and 23, 2014

**Representative test engineer:**

  
Hiroshi Kukita  
Engineer of WiSE Japan,  
UL Verification Service

**Approved by:**

  
Masanori Nishiyama  
Manager of WiSE Japan,  
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. \*As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

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13-EM-F0429



<b>CONTENTS</b>	<b>PAGE</b>
<b>SECTION 1: Customer information</b> .....	<b>4</b>
<b>SECTION 2: Equipment under test (E.U.T.)</b> .....	<b>4</b>
<b>SECTION 3: Test specification, procedures &amp; results</b> .....	<b>5</b>
<b>SECTION 4: Operation of E.U.T. during testing</b> .....	<b>8</b>
<b>SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)</b> .....	<b>10</b>
<b>SECTION 6: Automatically deactivate</b> .....	<b>11</b>
<b>SECTION 7: -20dB and 99% Occupied Bandwidth</b> .....	<b>11</b>
<b>APPENDIX 1: Data of EMI test</b> .....	<b>12</b>
Automatically deactivate.....	12
Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission).....	13
-20dB and 99% Occupied Bandwidth.....	14
Duty Cycle .....	15
<b>APPENDIX 2: Test Instruments</b> .....	<b>16</b>
<b>APPENDIX 3: Photographs of test setup</b> .....	<b>17</b>
Radiated emission .....	17
Worst case position .....	18

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## **SECTION 1: Customer information**

Company Name : Mitsubishi Electric Corporation Himeji works  
Address : 840 Chiyoda-machi Himeji Hyogo, 670-8677, Japan  
Telephone Number : +81-79-298-7363  
Facsimile Number : +81-79-298-9929  
Contact Person : Shinichi Furuta

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment : Smart Keyless System (Hand Unit)  
Model No. : SKEA7A-02  
Serial No. : Refer to Clause 4.2  
Rating : DC 3.0V  
Receipt Date of Sample : January 21, 2014  
Country of Mass-production : Japan  
Condition of EUT : Production prototype  
(Not for Sale: This sample is equivalent to mass-produced items.)  
Modification of EUT : No Modification by the test lab

### **2.2 Product Description**

Model No: SKEA7A-02 (referred to as the EUT in this report) is the Smart Keyless System (Hand Unit).  
The clock frequency of EUT is 615.2 kHz (2MHz) (CPU) and 9.84375 MHz (RF IC).

### **Radio Specification**

#### **RF Part**

Equipment Type : Transmitter  
Frequency band : 314.95MHz - 315.05MHz  
Type of modulation : FSK  
Bandwidth : 100kHz  
Frequency of operation : 315MHz  
Other clock frequency : 615.2kHz  
Antenna Type : PCB Pattern  
Method of Frequency Generation : Crystal  
Operating voltage (inner) : DC +3.0V

#### **LF Part \***

Type of Receiver : Receiver  
Frequency of operation : 125kHz  
Other clock frequency : 9.84375MHz  
Intermediate frequency : -  
Antenna Type : Inductive  
Method of Frequency Generation : Crystal  
Operating voltage (inner) : DC +3.0V

\* EUT also has this function. Please refer to No. 10131705H-D (FCC15B).

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## **SECTION 3: Test specification, procedures & results**

### **3.1 Test Specification**

Test Specification : FCC Part 15 Subpart C: 2013, final revised on September 30, 2013 and effective October 30, 2013

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.231 Periodic operation in the band 40.66 - 40.70MHz and above 70MHz

### **3.2 Procedures and results**

<b>Item</b>	<b>Test Procedure</b>	<b>Specification</b>	<b>Worst margin</b>	<b>Results</b>	<b>Remarks</b>
Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements ----- IC: RSS-Gen 7.2.4	FCC: Section 15.207 ----- IC: RSS-Gen 7.2.4	N/A	N/A *1)	-
Automatically Deactivate	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: -	FCC: Section 15.231(a)(1) ----- IC: RSS-210 A1.1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: RSS-Gen 4.8	FCC: Section 15.231(b) ----- IC: RSS-210 A1.1.2	2.9dB 315.00MHz Horizontal PK with Duty factor	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: RSS-Gen 4.9	FCC: Section 15.205 Section 15.209 Section 15.231(b) ----- IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 7.2.5	1.6dB 2835.000MHz Horizontal PK with Duty factor	Complied	Radiated
-20dB Bandwidth	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: -	FCC: Section 15.231(c) ----- IC: Reference data	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

\*1) The test is not applicable since the EUT does not have AC Mains.

#### **FCC 15.31 (e)**

This test was performed with the New Battery (DC 3.0V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

#### **FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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### 3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

#### EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.0dB	5.1dB	5.0dB	5.1dB	6.0dB	4.9dB	4.3dB
No.2	3.9dB	5.2dB	5.0dB	4.9dB	5.9dB	4.7dB	4.2dB
No.3	4.3dB	5.1dB	5.2dB	5.2dB	6.0dB	4.8dB	4.2dB
No.4	4.6dB	5.2dB	5.0dB	5.2dB	6.0dB	5.7dB	4.2dB

\*3m/1m/0.5m = Measurement distance

#### Radiated emission test(3m)

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

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### 3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	-	6.2 x 4.7 x 3.0m	2.4 x 3.4m	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Data of EMI, Test instruments, and Test set up.

Refer to APPENDIX.

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## **SECTION 4: Operation of E.U.T. during testing**

### **4.1 Operating Modes**

<b>Test Item*</b>	<b>Mode</b>
Automatically Deactivate	Normal use mode 315MHz
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20dB & 99% Occupied Bandwidth Duty Cycle	Transmitting mode (Tx) 315MHz *1)
* The system was configured in typical fashion (as a customer would normally use it) for testing. *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, EUT stops to transmit in a given time, even if transceiver button is being pressed.) End users cannot change the settings of the output power of the product.	

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## 4.2 Configuration and peripherals

**This page has been submitted for a separate exhibit.**

## **SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)**

### **Test Procedure and conditions**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The EUT was set on the center of the tabletop.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

Photographs of the set up are shown in Appendix 3.

### **[Transmitting mode]**

#### **(Below 30MHz)**

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

#### **(Above 30MHz)**

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3m.

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver/spectrum analyzer.

### **Test Antennas are used as below;**

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9kHz to 90kHz and From 110kHz to 150kHz	From 90kHz to 110kHz	From 150kHz to 490kHz	From 490kHz to 30MHz	From 30MHz to 1GHz	Above 1GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200Hz	200Hz	9.1kHz	9.1kHz	120kHz	PK: S/A:RBW 1MHz, VBW 3MHz

- The carrier level was measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is folded in or out. The worst case was confirmed that mechanical key is folded in or out, as a result, the test which mechanical key was folded out was the worst case. Therefore the test was performed under the worst condition.

\*The result is rounded off to the second decimal place, so some differences might be observed.

**Measurement range** : 9kHz-3.2GHz  
**Test data** : APPENDIX 1  
**Test result** : Pass

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## **SECTION 6: Automatically deactivate**

### **Test Procedure**

The measurement was performed with Electric field strength using a spectrum analyzer.

**Test data** : APPENDIX 1  
**Test result** : Pass

## **SECTION 7: -20dB and 99% Occupied Bandwidth**

### **Test Procedure**

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20dB Bandwidth	300kHz	3kHz	9.1kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 % of Span	Three times of RBW	Auto (Single)	Sample	Max Hold	Spectrum Analyzer

**Test data** : APPENDIX 1  
**Test result** : Pass

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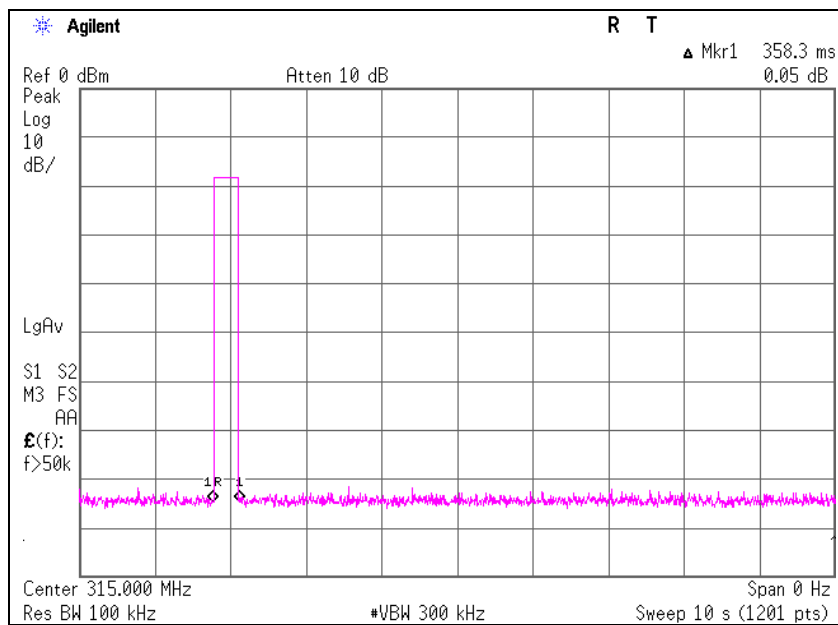
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**APPENDIX 1: Data of EMI test**

**Automatically deactivate**

Test place Head Office EMC Lab. No.1 Semi Anechoic Chamber  
 Report No. 10131705H  
 Date 01/23/2014  
 Temperature/ Humidity 22 deg. C / 30% RH  
 Engineer Masatoshi Nishiguchi  
 Mode Normal use mode 315MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.3583	5.00	Pass



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## Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place	Head Office EMC Lab. No.4 Semi Anechoic Chamber
Report No.	10131705H
Date	01/21/2014
Temperature/ Humidity	19 deg. C / 33% RH
Engineer	Hiroshi Kukita
Mode	Transmitting mode 315MHz

**PK**

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	78.3	72.5	16.4	10.0	32.0	-	72.7	66.9	95.6	22.9	28.7	Carrier
630.000	PK	35.7	32.1	20.8	11.9	32.2	-	36.2	32.6	75.6	39.4	43.0	Outside
945.000	PK	34.6	31.0	25.4	13.5	31.0	-	42.5	38.9	75.6	33.1	36.7	Outside
1260.000	PK	57.8	58.7	25.1	1.9	34.2	-	50.6	51.5	75.6	25.0	24.1	Outside
1575.000	PK	56.2	55.5	25.9	2.1	33.4	-	50.8	50.1	73.9	23.1	23.8	Inside
1890.000	PK	48.3	48.8	26.6	2.3	32.9	-	44.3	44.8	75.6	31.3	30.8	Outside
2205.000	PK	52.9	51.3	27.6	2.5	32.5	-	50.5	48.9	73.9	23.4	25.0	Inside
2520.000	PK	54.5	53.0	28.7	2.7	32.4	-	53.5	52.0	75.6	22.1	23.6	Outside
2835.000	PK	52.5	49.4	29.1	2.9	32.2	-	52.3	49.2	73.9	21.6	24.7	Inside
3150.000	PK	45.3	47.5	29.4	3.0	32.1	-	45.6	47.8	75.6	30.0	27.8	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

**AV (PK with Duty factor)**

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	78.3	72.5	16.4	10.0	32.0	0.0	72.7	66.9	75.6	2.9	8.7	Carrier
630.000	PK	35.7	32.1	20.8	11.9	32.2	0.0	36.2	32.6	55.6	19.4	23.0	Outside
945.000	PK	34.6	31.0	25.4	13.5	31.0	0.0	42.5	38.9	55.6	13.1	16.7	Outside
1260.000	PK	57.8	58.7	25.1	1.9	34.2	0.0	50.6	51.5	55.6	5.0	4.1	Outside
1575.000	PK	56.2	55.5	25.9	2.1	33.4	0.0	50.8	50.1	53.9	3.1	3.8	Inside
1890.000	PK	48.3	48.8	26.6	2.3	32.9	0.0	44.3	44.8	55.6	11.3	10.8	Outside
2205.000	PK	52.9	51.3	27.6	2.5	32.5	0.0	50.5	48.9	53.9	3.4	5.0	Inside
2520.000	PK	54.5	53.0	28.7	2.7	32.4	0.0	53.5	52.0	55.6	2.1	3.6	Outside
2835.000	PK	52.5	49.4	29.1	2.9	32.2	0.0	52.3	49.2	53.9	1.6	4.7	Inside
3150.000	PK	45.3	47.5	29.4	3.0	32.1	0.0	45.6	47.8	55.6	10.0	7.8	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

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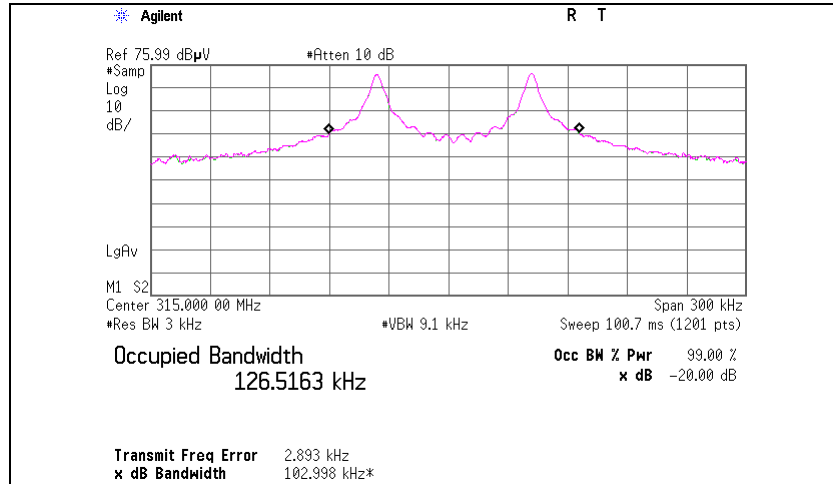
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**-20dB and 99% Occupied Bandwidth**

Test place	Head Office EMC Lab. No.4 Semi Anechoic Chamber
Report No.	10131705H
Date	01/21/2014
Temperature/ Humidity	19 deg. C / 33% RH
Engineer	Hiroshi Kukita
Mode	Transmitting mode 315MHz

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
103.00	787.50	Pass

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
126.52	787.50	Pass



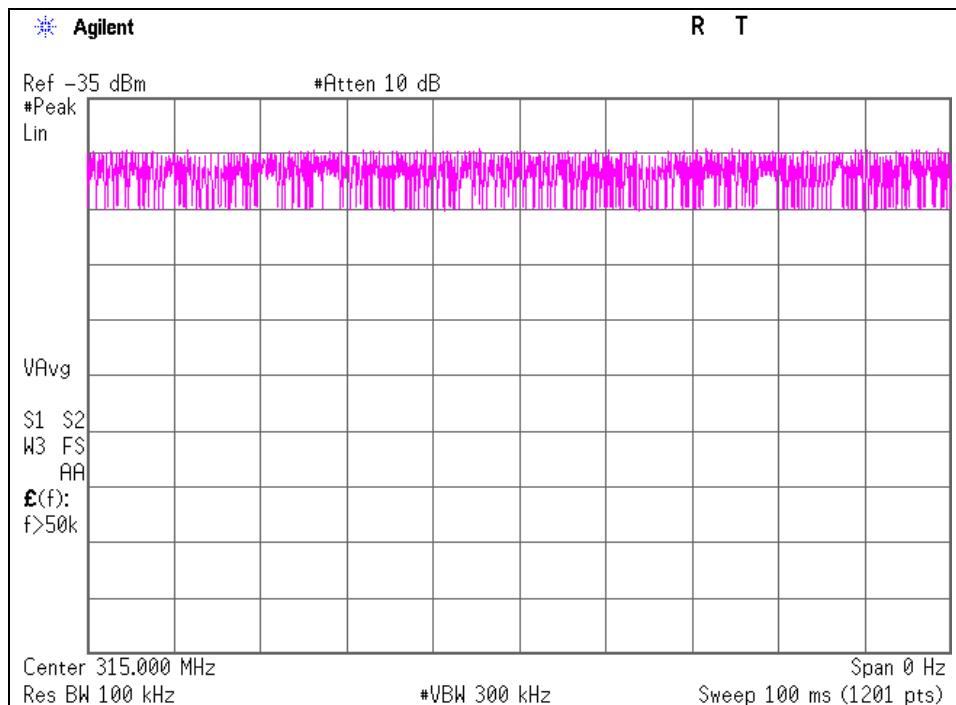
### Duty Cycle

Test place	Head Office EMC Lab. No.4 Semi Anechoic Chamber
Report No.	10131705H
Date	01/21/2014
Temperature/ Humidity	19 deg. C / 33% RH
Engineer	Hiroshi Kukita
Mode	Transmitting mode 315MHz

(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
100.000	100.00	1.0000	0.00

\*4) Duty =  $20\log_{10}(\text{ON time}/\text{Cycle})$



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## **APPENDIX 2: Test Instruments**

### **EMI test equipment**

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2013/02/28 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	-	RE	2013/02/26 * 12
MJM-09	Measure	KDS	E19-55	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MRENT-112	Spectrum Analyzer	Agilent	E4440A	MY48250080	RE	2013/10/04 * 12
MTR-01	Test Receiver	Rohde & Schwarz	ES140	100084	RE	2013/11/12 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	1302	RE	2013/11/24 * 12
MLA-08	Logperiodic Antenna	Schwarzbeck	UKLP9140-A	N/A	RE	2013/11/24 * 12
MCC-50	Coaxial Cable	UL Japan	-	-	RE	2013/06/18 * 12
MAT-68	Attenuator	Anritsu	MP721B	6200961025	RE	2013/11/26 * 12
MPA-14	Pre Amplifier	SONOMA INSTRUMENT	310	260833	RE	2013/03/12 * 12
MHA-21	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	RE	2013/08/12 * 12
MCC-141	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1204S062(5m)	RE	2013/05/28 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	MY39500780	RE	2013/03/19 * 12
MLPA-01	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	RE	2013/10/30 * 12
MCC-113	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W(10m)/ SFM141(5m)/ 421-010(1m)/ sucoform141-PE(1m)/ RFM-E121(Switcher)	-/04178	RE	2013/07/23 * 12
MCC-143	Coaxial Cable	UL Japan	-	-	RE	2013/07/22 * 12

**The expiration date of the calibration is the end of the expired month.**

**All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.**

**As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.**

**Test Item:**

**RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth, Automatically deactivate and Duty cycle tests**

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